

Notice of References Cited	Application/Control No. 10/695,895	Applicant(s)/Patent Under Reexamination OHKI ET AL.	
	Examiner Mark L. Berch	Art Unit 1624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0004094	01-2005	Yamanaka et al.	514/202
*	B	US-2005/0096306	05-2005	Yamanaka et al.	514/202
*	C	US-2004/0248875	12-2004	Ohki et al.	514/202
	D	US-			
	E	US-			
	F	US-			
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	J	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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